

Si metal-oxide-semiconductor field-effect transistor for THz detection

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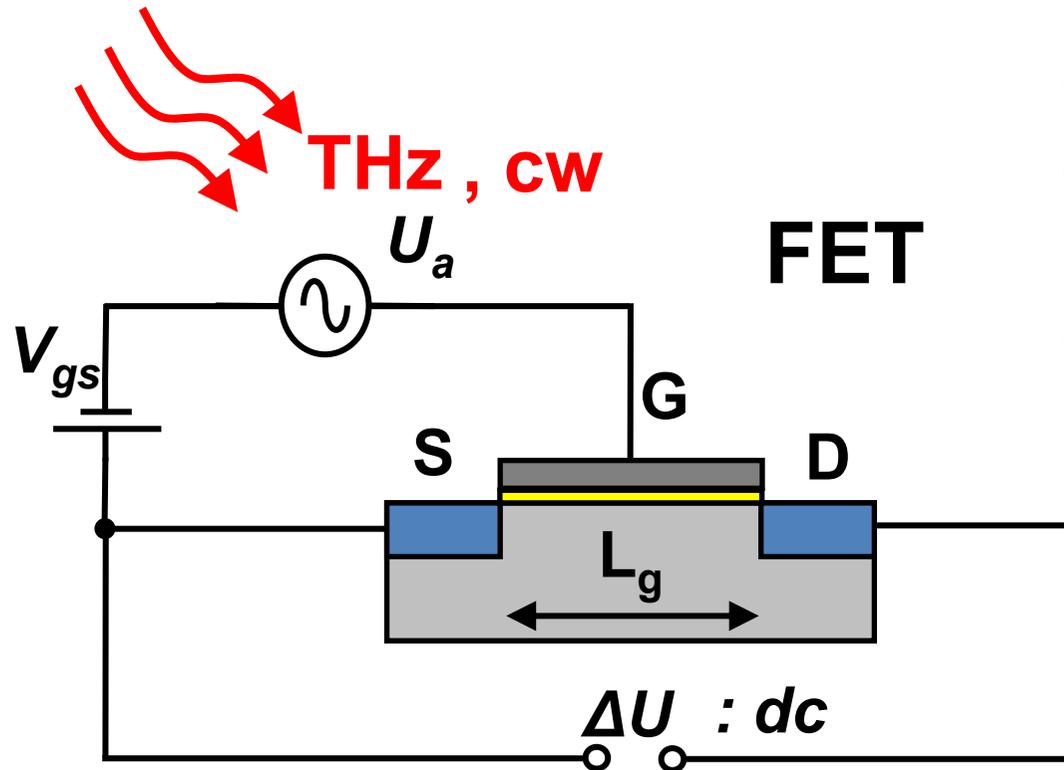


“Functional Nanomaterials and Devices....”, Kyiv, April 8-11, 2013

Outline

- 1. Introduction - Si MOSFETs as THz detectors**
- 2. Design and fabrication of detectors**
- 3. Results: resonant detection @ 340 GHz**
- 4. Conclusions**

Experiments on THz excitations in FETs



- V_{gs} : Source-Gate bias
- U_a : irradiation induced *ac* voltage
- ΔU : *dc* photoresponse

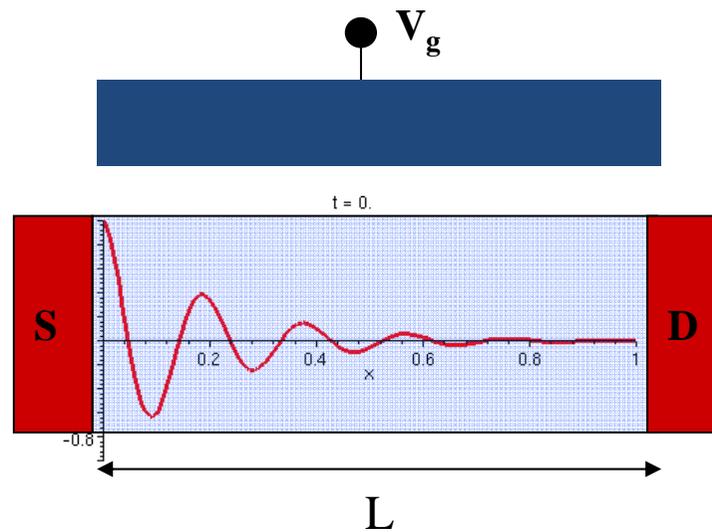
**!!Nonlinearity – THz modulates simultaneously
!!carrier density and drift velocity!!**

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Regimes of plasma waves (high mobility/ frequency)

$\omega\tau \gg 1$ Plasma waves are weakly damped

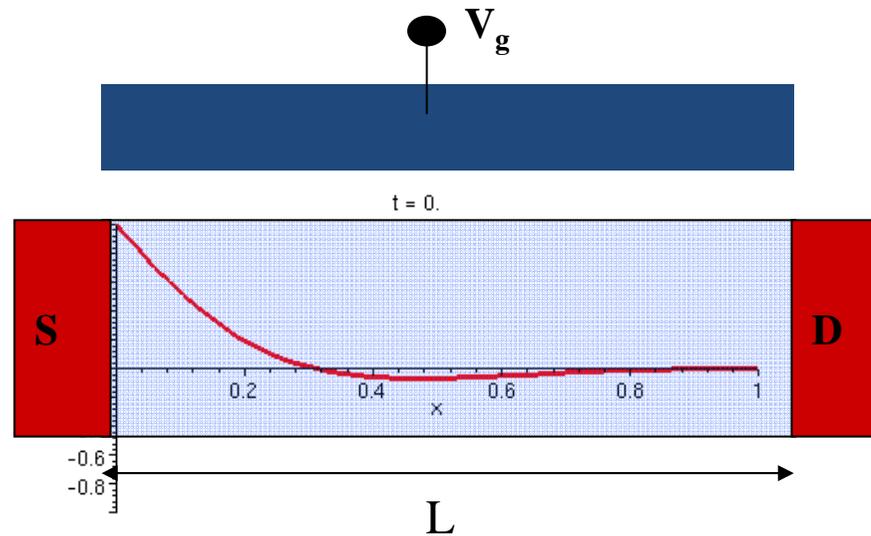
Characteristic damping length: $l = s\tau$



Long gate: $L \gg s\tau$

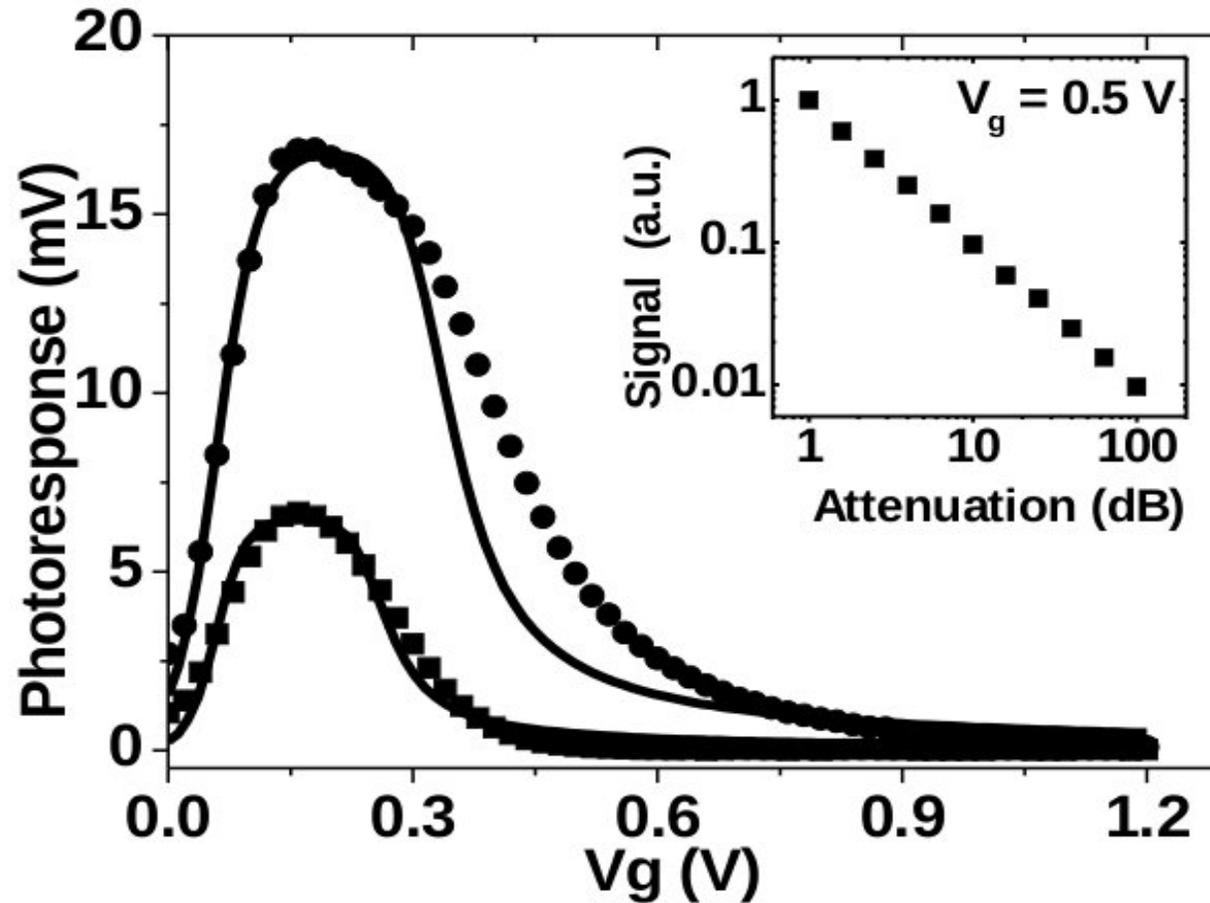
300K , Silicon – low mobility - overdamped plasma oscillations

$$\omega\tau \ll 1$$



Characteristic length: $l = s \sqrt{\tau / \omega}$

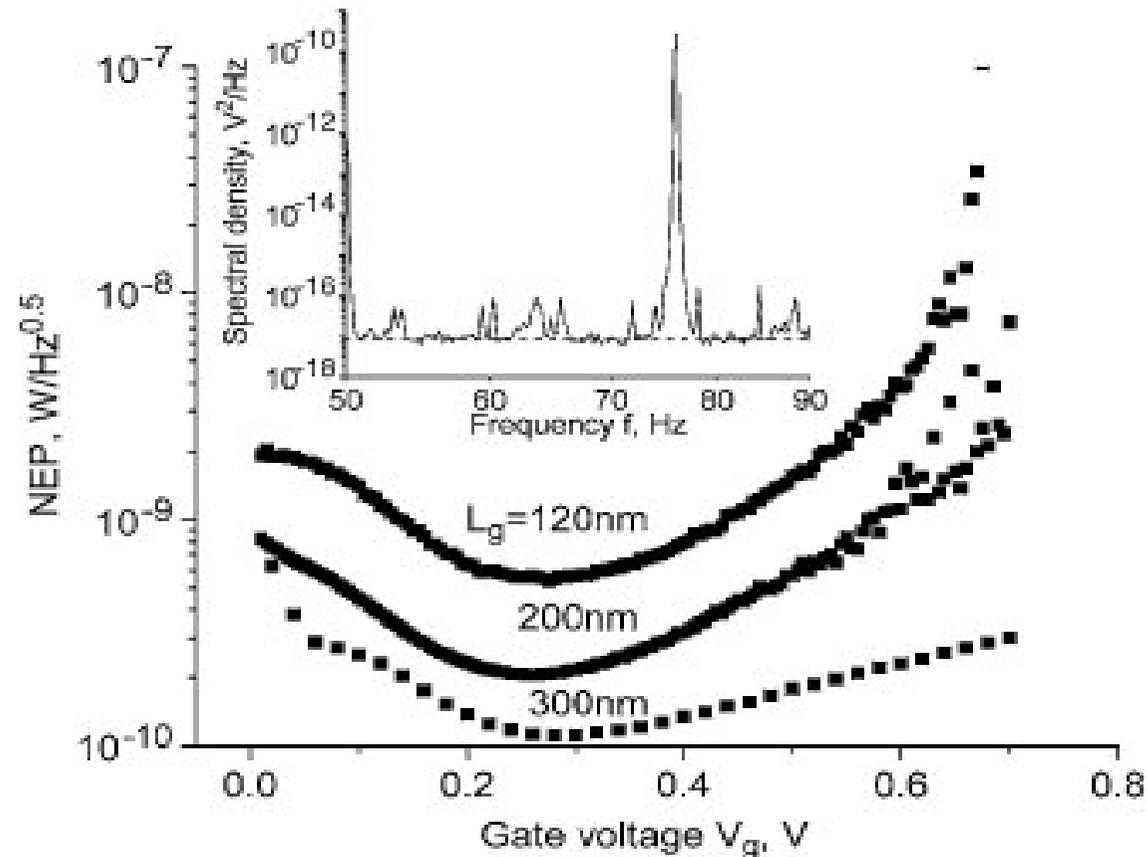
Si MOSFETs as THz detectors (2)



Plasma wave detection of sub-terahertz and terahertz radiation by silicon field-effect transistors

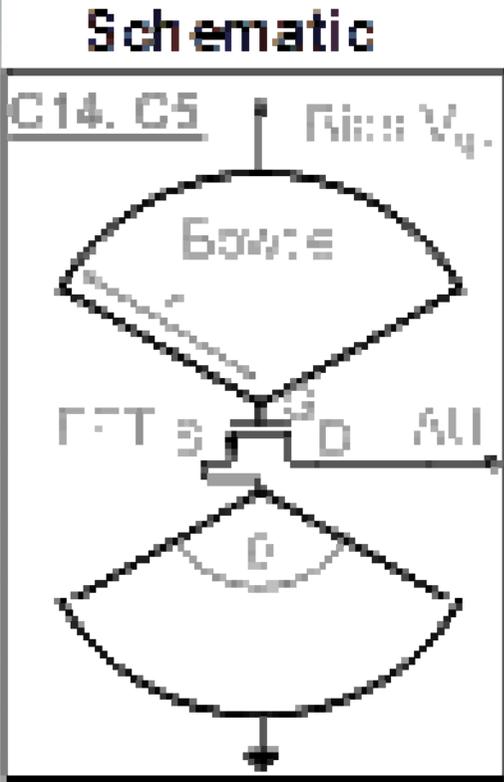
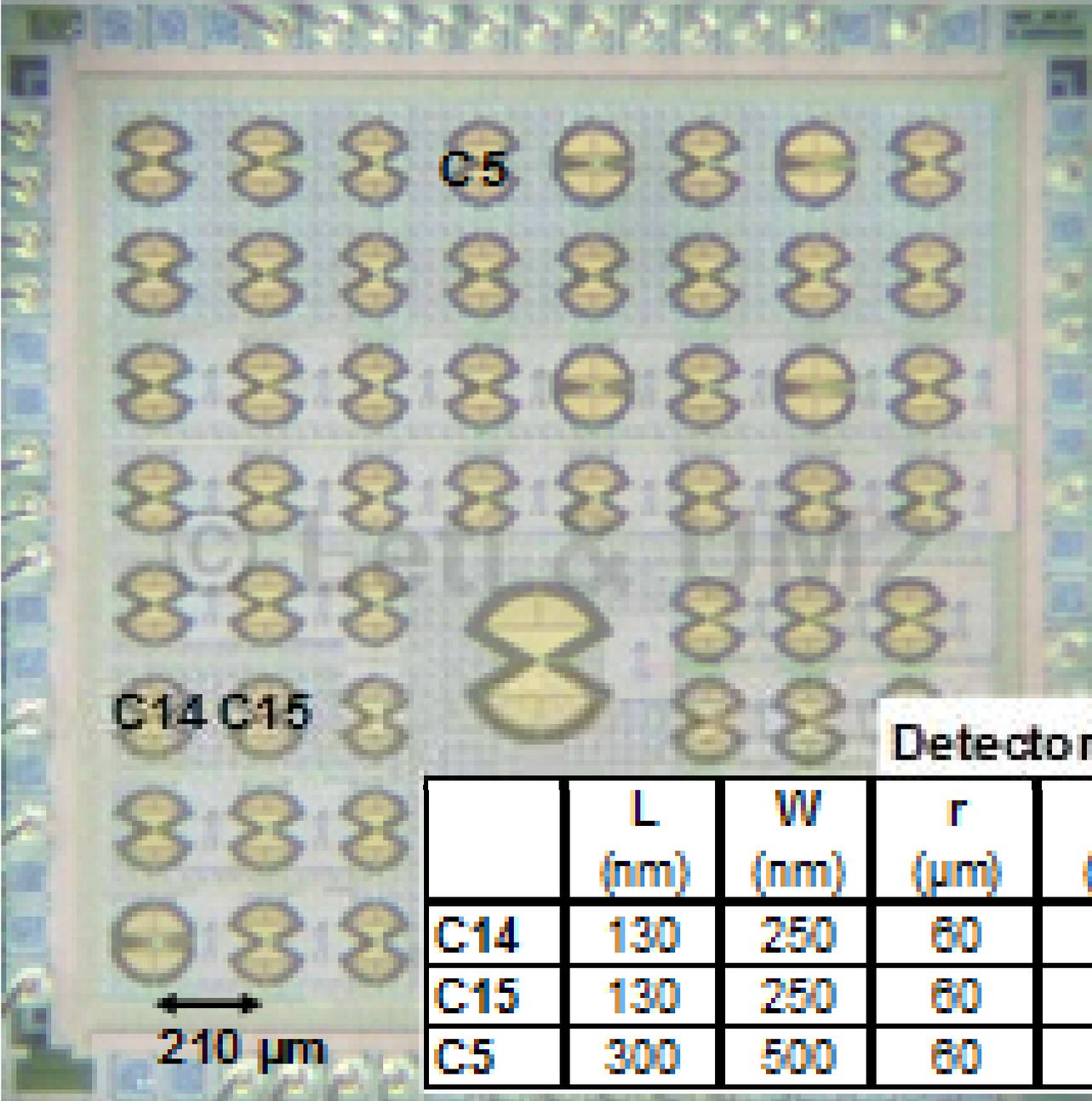
W. Knap et al., Appl. Phys. Lett. 85, 675 (2004)

Si MOSFETs as THz detectors (3)



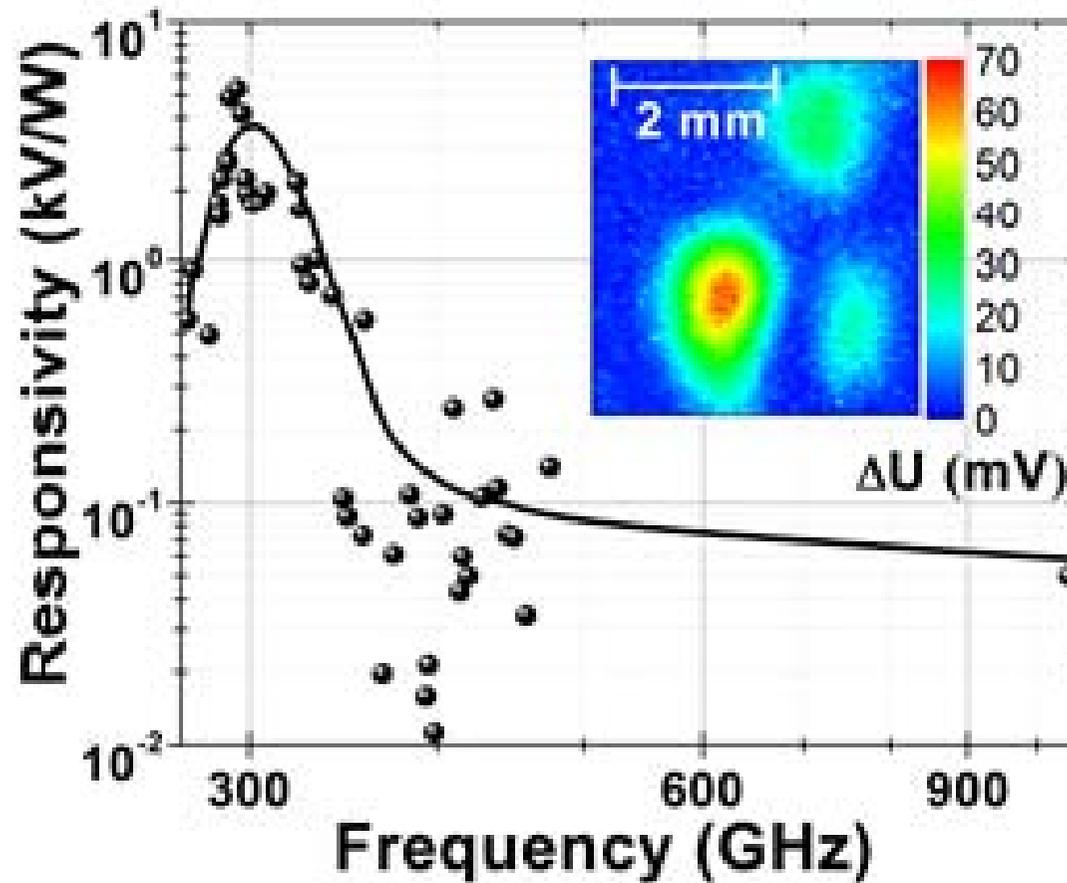
**Plasma wave detection of terahertz radiation by silicon field-effect transistors:
Responsivity and noise equivalent power
R. Tauk et al., Appl. Phys. Lett. 89, 253511 (2006)**

0.13μm CMOS



Detector Characteristics

	L (nm)	W (nm)	r (μm)	θ (deg)	Antenna Connection
C14	130	250	60	120	gate-source
C15	130	250	60	120	source-drain
C5	300	500	60	120	gate-source



"Broadband terahertz imaging with highly sensitive silicon CMOS detectors,"

F.Schuster et al

Optics Express, vol. 19, pp. 7827-7832, (2011)

Laser Focus World, vol. 47(7), pp. 37-41, (2011)

Si MOSFETs as THz detectors (5)

Main directions of development:

(Germany, USA, Japan & Poland ITE initiative)

- multipixel arrays , - heterodyne detection

- on-chip integration with amplifiers

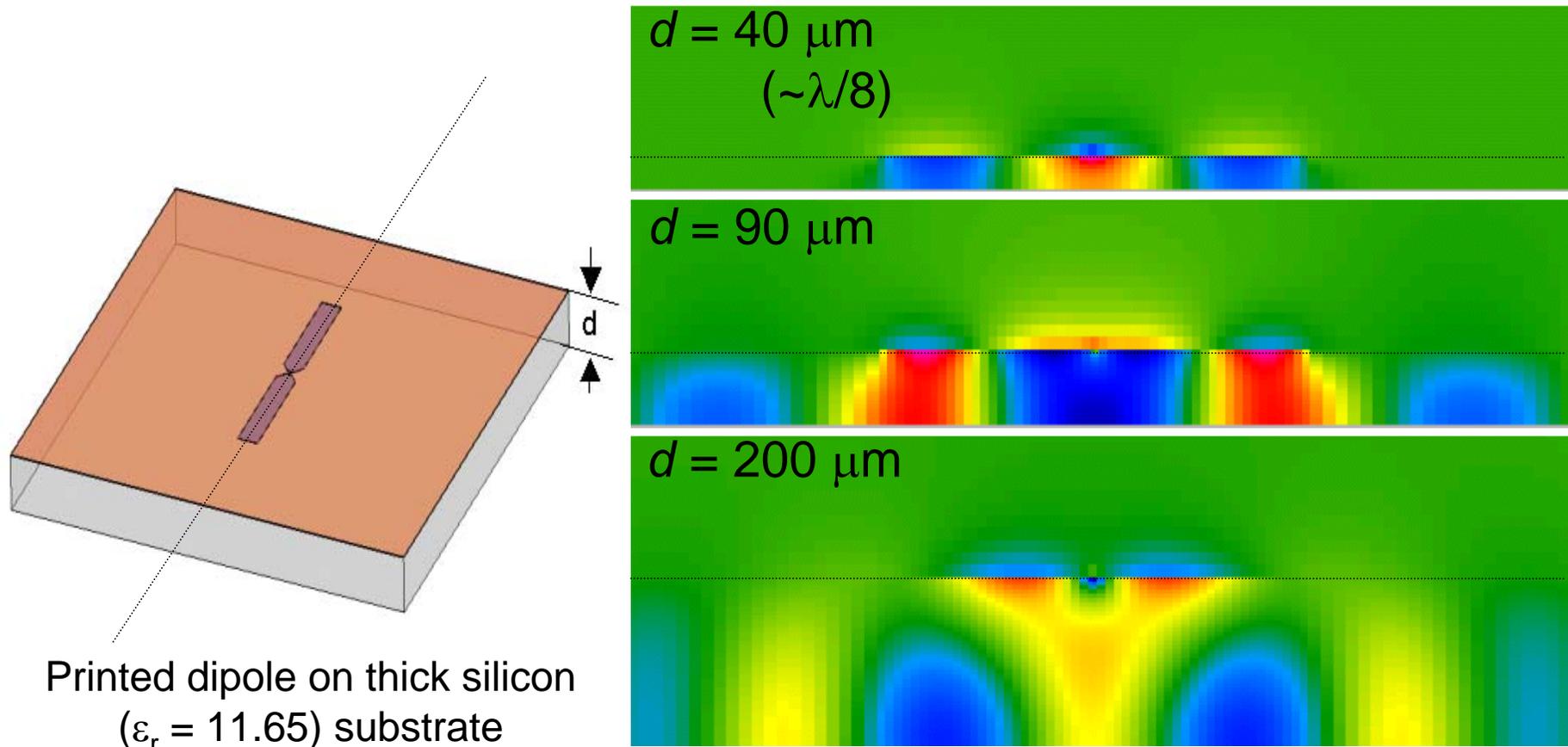
- special antennas design

-(ITE, PW, WAT, UV initiative)

The goal:

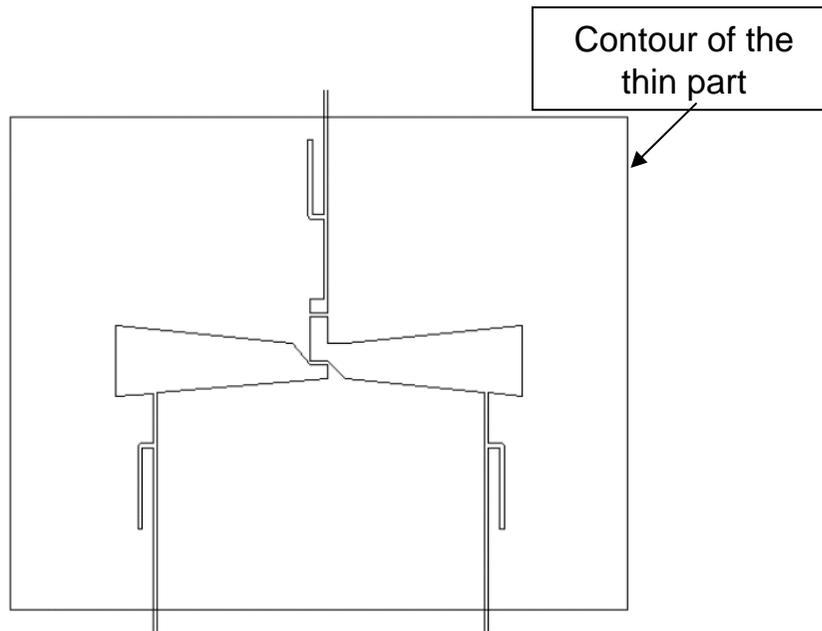
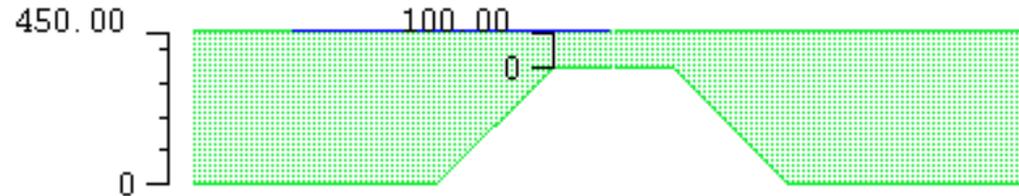
to achieve a resonant (spectrally narrow) response with a non-resonant (spectrally broad) MOSFET

Antennas design and technology (2)

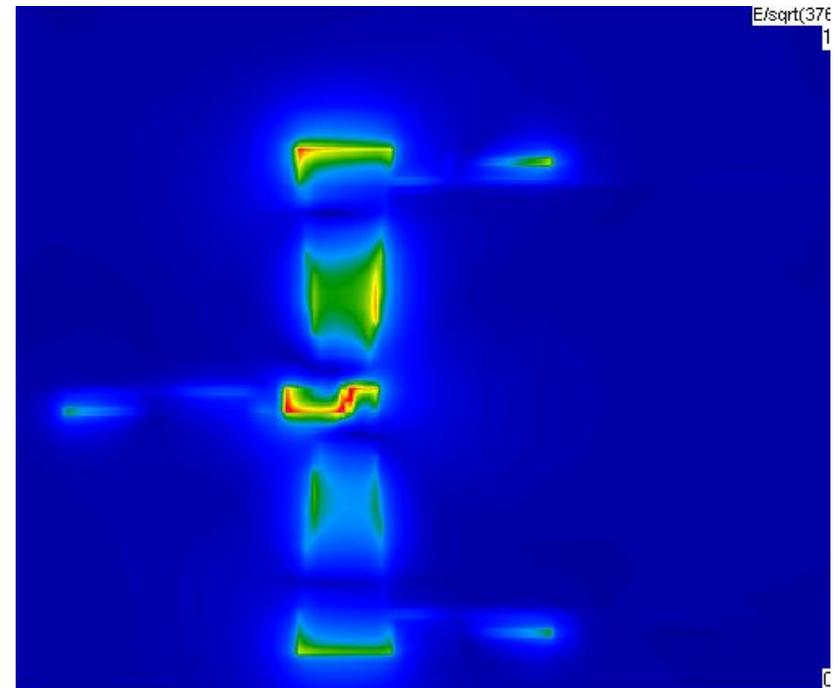


Instantaneous H-field distribution in the axial-plane of antenna ($f = 300$ GHz)

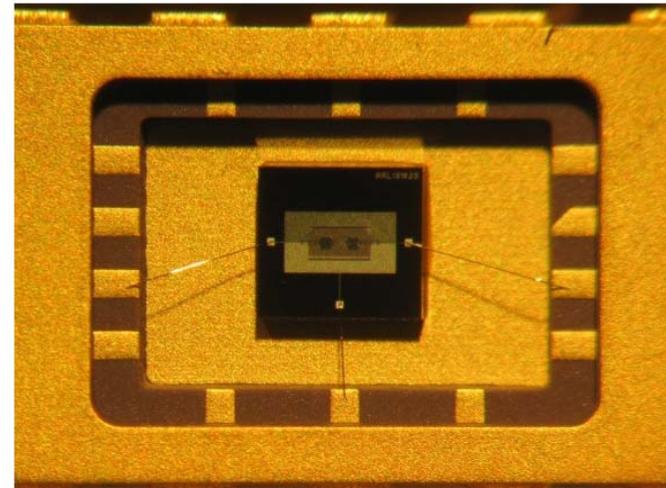
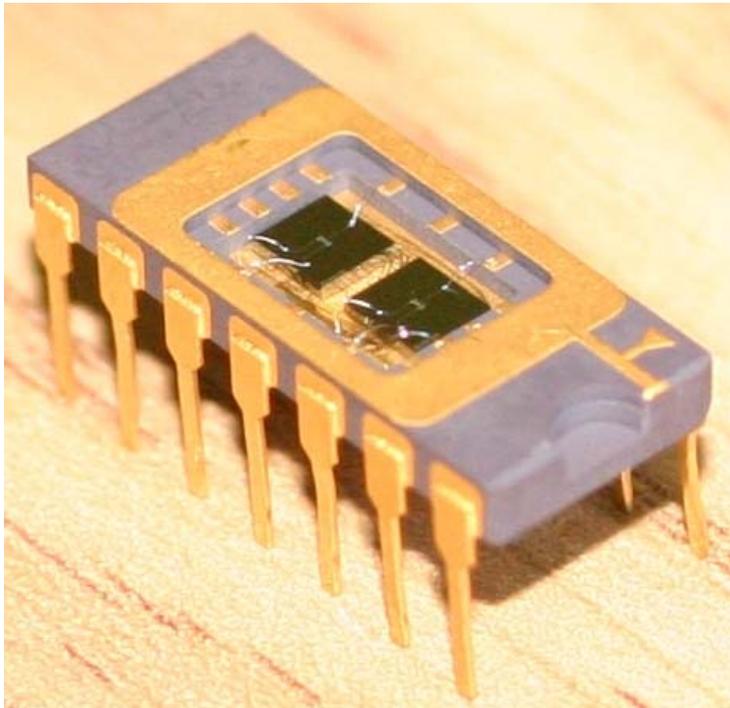
Antennas design and technology (3)

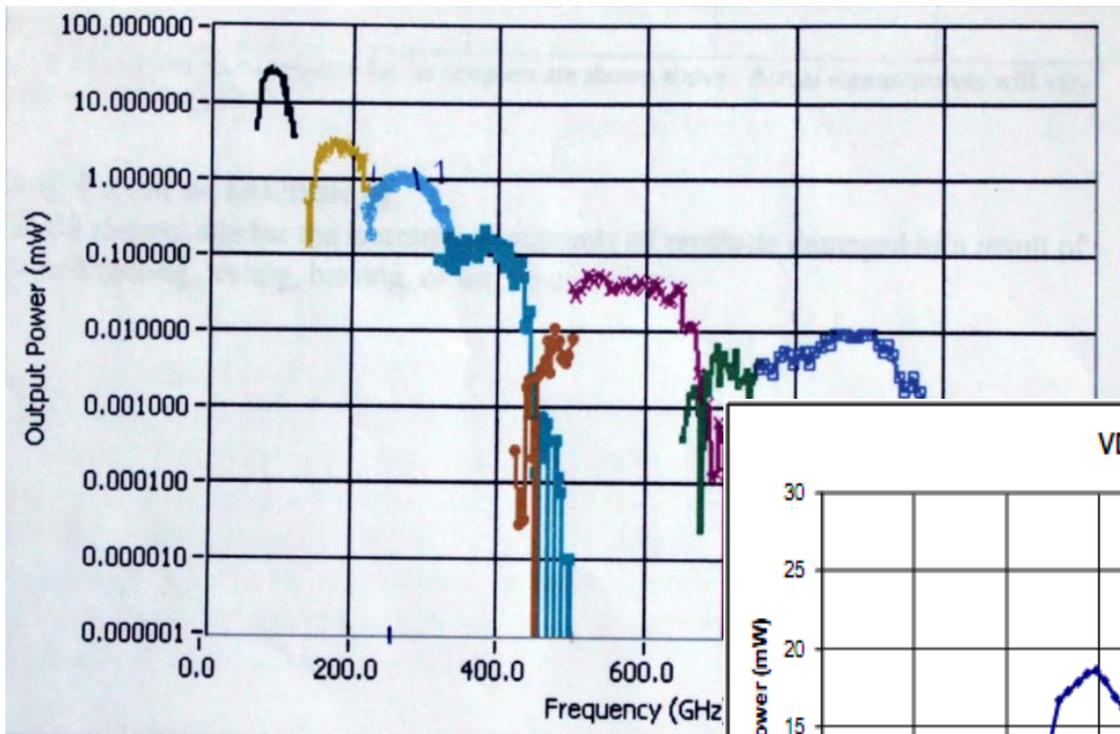


Example geometry of bow-tie antenna on thinned-down substrate

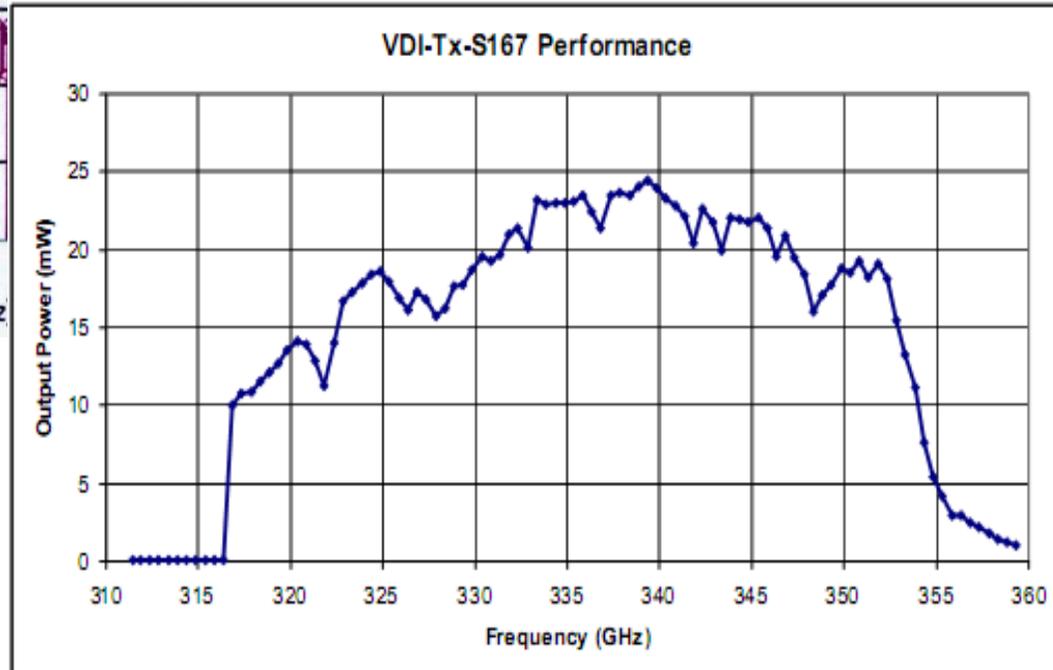


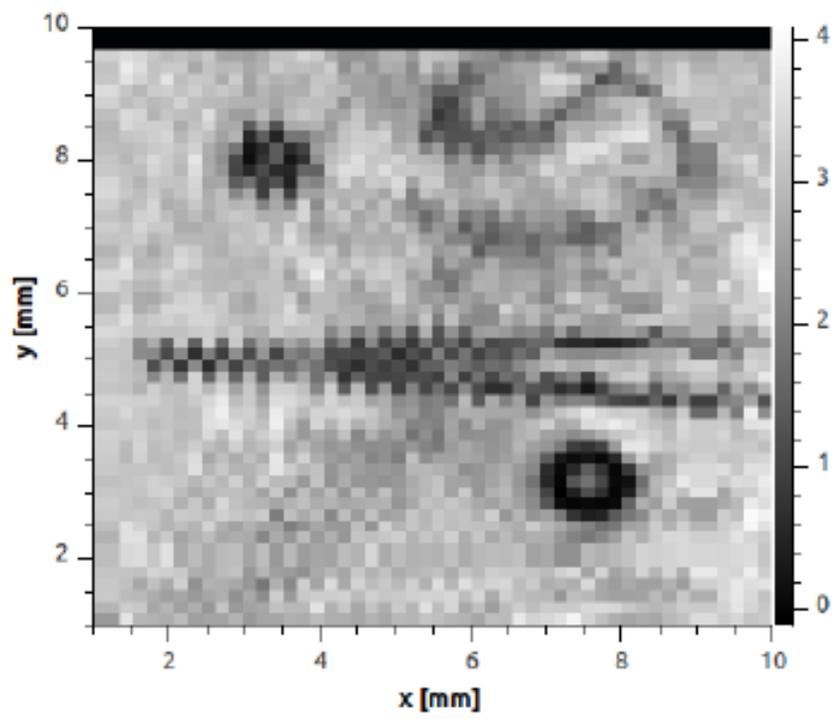
The dominating E-field component magnitude (TM_{00})

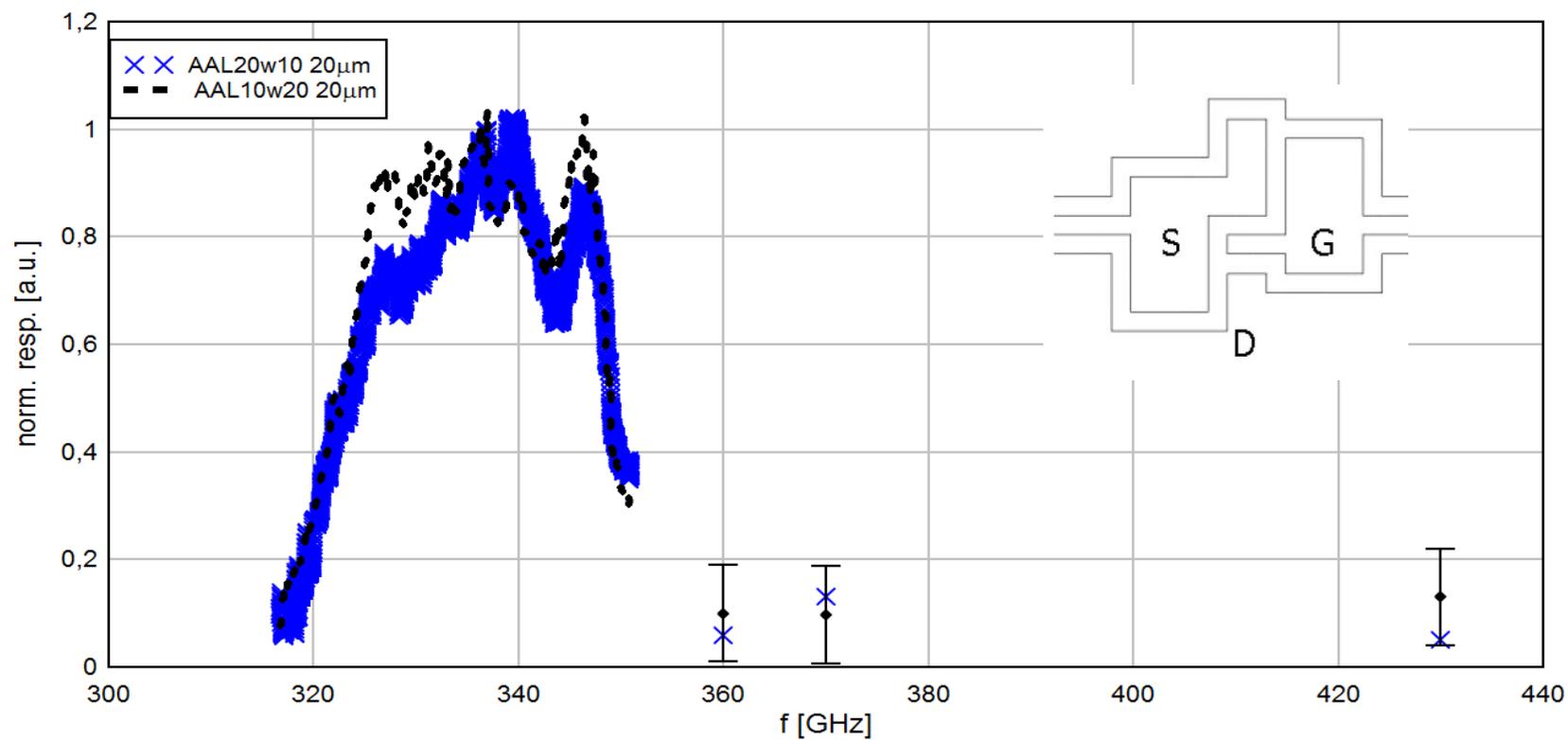




VDI multipliers

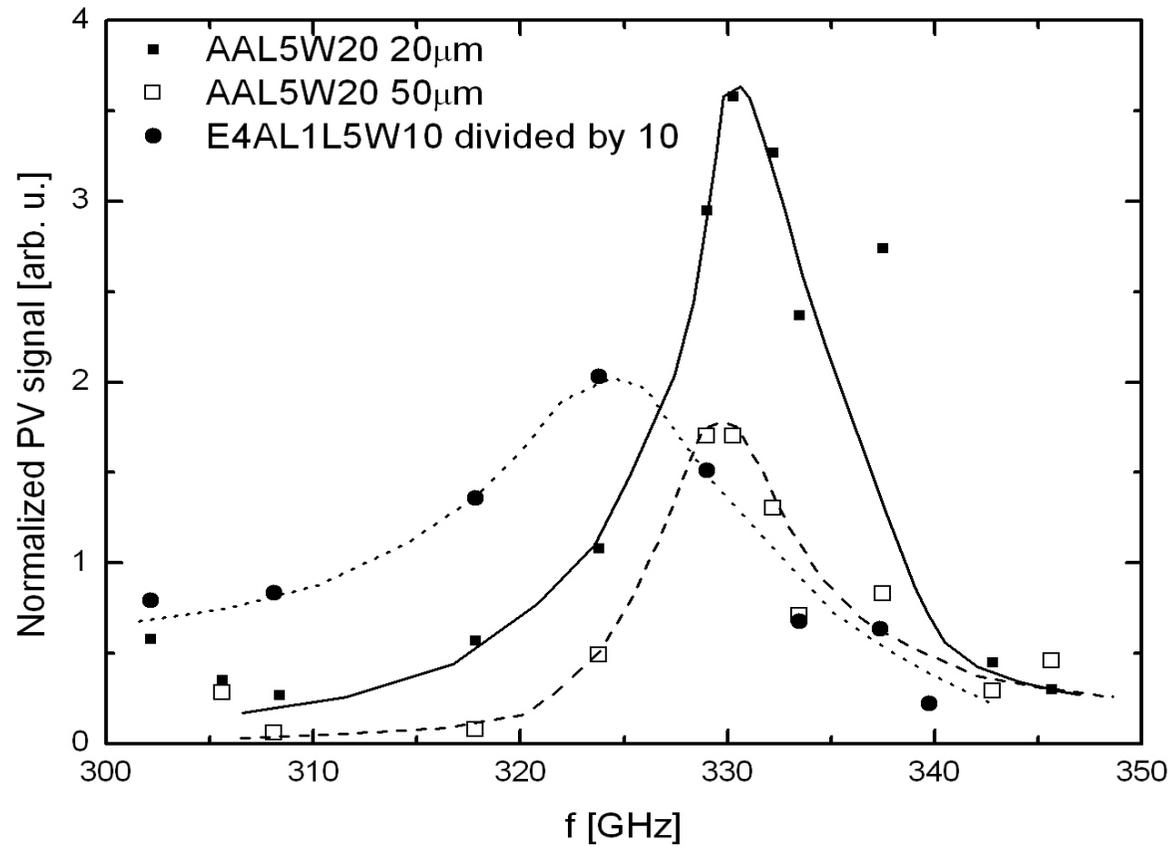






Antennas were calculated for $f=340\text{GHz}$,
 $\Delta f=20\text{GHz}$

Experiment and results (2)



Conclusions

- 1. Original Si FET technology for THz detectors**
- 2. Good results for detectors fabricated on a thinned substrate**
- 3. A sharp resonances around 300GHz suitable for spectroscopy applications**

Acknowledgments



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by The National Centre for Research and Development, Poland
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"Multipixel detector of THz radiation based on selective MOS transistors and its application in biology, medicine and safety installations", PBS1/A9/11/2012

Thank You – recent references to review papers

W. Knap and M. I. Dyakonov, *'Field effect transistors for terahertz applications'* in D. Saeedkia, **Handbook of terahertz technology for imaging, sensing and communications**, Cambridge, Woodhead Publishing, 121-155(2013)

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W Knap, S Rummyantsev, M S Vitiello, D Coquillat, S Blin, M Shur, A Tredicucci and T Nagatsuma *Nanometer size field effect transistors for terahertz detectors* **Nanotechnology 24 (2013)**

